Search Notes



Application/Control No.

10643422

Reexamination
TANAKA ET AL.

Applicant(s)/Patent Under

Examiner

Kim-Kwok CHU

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
369	47.16	6/4/2010	kc
369	59.26	6/4/2010	kc
84	631	6/4/2010	kc
84	600	6/4/2010	kc
84	632	6/4/2010	kc
386	52	6/4/2010	kc
386	46	6/4/2010	kc
709	217	6/4/2010	kc

SEARCH NOTES

Search Notes	Date	Examiner
East Search Updated	6/4/2010	kc
Inventors Search	6/4/2010	kc

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
369	47.16	6/4/2010	kc
369	59.25	6/4/2010	kc
386	46	6/4/2010	kc
386	52	6/4/2010	kc
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U.S. Patent and Trademark Office Part of Paper No.: 20100705